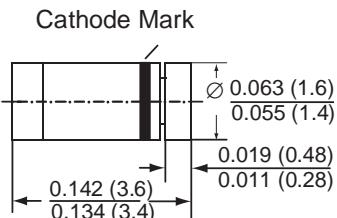


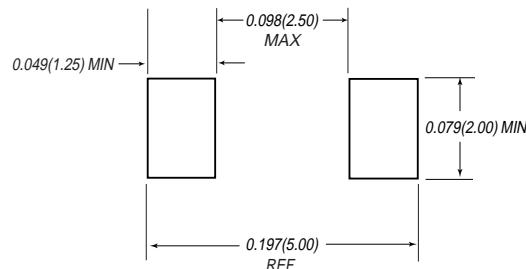


### MiniMELF (SOD-80C)



Dimensions in inches and (millimeters)

### Mounting Pad Layout



### Mechanical Data

**Case:** MiniMELF Glass Case (SOD-80C)

**Weight:** approx. 0.05g

**Cathode band color:** Blue

**Packaging codes/options:**

D1/10K per 13" reel (8mm tape), 20K/box  
D2/2.5K per 7" reel (8mm tape), 20K/box

### Features

- Silicon Planar Stabilizer Diodes
- Monolithic integrated analog circuits in MiniMELF case, designed for small power stabilizer and limitation circuits, providing low dynamic resistance and high-quality stabilization performance as well as low noise. In the reverse direction, these devices show the behavior of forward-biased silicon diodes.
- The end of the device marked with the cathode ring is to be connected: LL1.5 and LL2 to the negative pole of the supply voltage; LL2.4 thru LL5.1 to the positive pole of the supply voltage
- These diodes are also available in DO-35 case with the type designation ZTE1.5 ... ZTE 5.1.

### Maximum Ratings (TA = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Operating Current (see Table "Characteristics")			
Inverse Current	I <sub>F</sub>	100	mA
Power dissipation at T <sub>amb</sub> = 25°C	P <sub>tot</sub>	300 <sup>(1)</sup>	W
Junction temperature	T <sub>J</sub>	150	°C
Storage temperature range	T <sub>S</sub>	-55 to +150	°C

### Electrical and Thermal Characteristics (TA = 25°C unless otherwise noted)

Parameter	Symbol	Min.	Typ.	Max.	Unit
Forward Voltage at I <sub>F</sub> = 10mA	V <sub>F</sub>	-	-	1.1	V
Temperature Coefficient of the stabilized voltage at I <sub>Z</sub> = 5mA	α <sub>YZ</sub> α <sub>VZ</sub>	-26 -34	-26 -34	-	10 <sup>-4</sup> /°C 10 <sup>-4</sup> /°C
Thermal resistance junction to ambient air	R <sub>θJA</sub>	-	-	400 <sup>(1)</sup>	°C/W

**Electrical Characteristics** ( $T_A = 25^\circ C$  unless otherwise noted)

Type	Operating Voltage at $I_Z = 5\text{mA}^{(2)}$ $V_Z (\Omega)$	Dynamic resistance at $I_Z = 5\text{mA}$ $r_{Zj} (\Omega)$	Permissible operating current at $T_{amb} = 25^\circ C^{(1)}$ $I_Z \text{ max. (mA)}$
LL1.5	1.35 ... 1.55	13(<20)	120
LL2	2.0 ... 2.3	18(<30)	120
LL2.4	2.2 ... 2.56	14(<20)	120
LL2.7	2.5 ... 2.9	15(<20)	105
LL3	2.8 ... 3.2	15(<20)	95
LL3.3	3.1 ... 3.5	16(<20)	90
LL3.6	3.4 ... 3.8	16(<25)	80
LL3.9	3.7 ... 4.1	17(<25)	75
LL4.3	4.0 ... 4.6	17(<25)	65
LL4.7	4.4 ... 5.0	18(<25)	60
LL5.1	4.8 ... 5.4	18(<25)	55

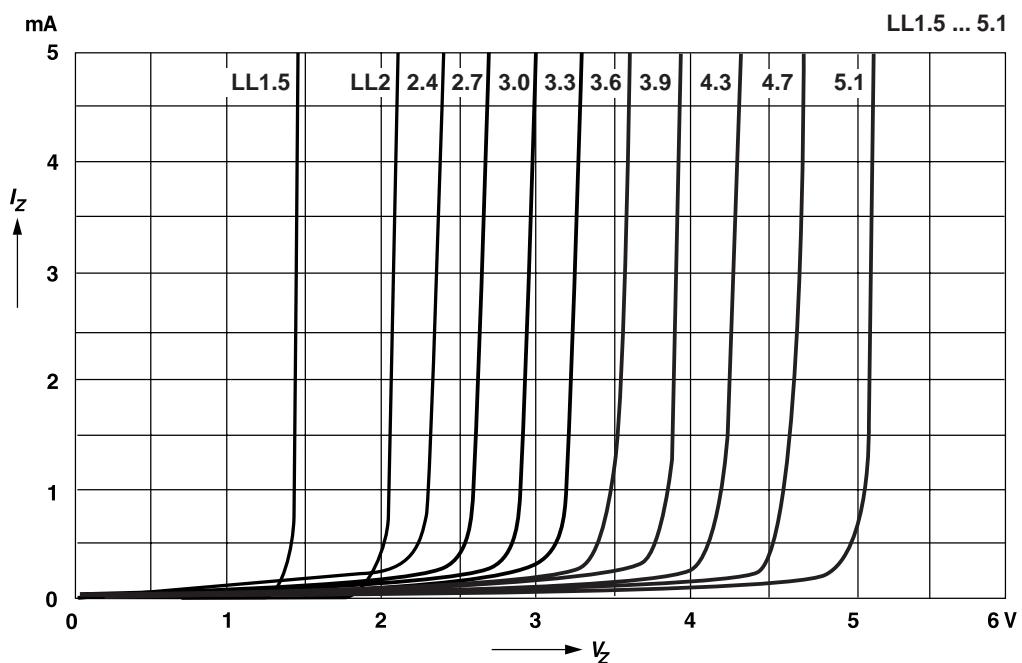
**Notes:** (1) Valid provided that electrodes are kept at ambient temperature at a distance of 8mm from case

(2) Tested with pulses  $t_p = 5\text{ms}$

**Ratings and  
Characteristic Curves** (T<sub>A</sub> = 25°C unless otherwise noted)

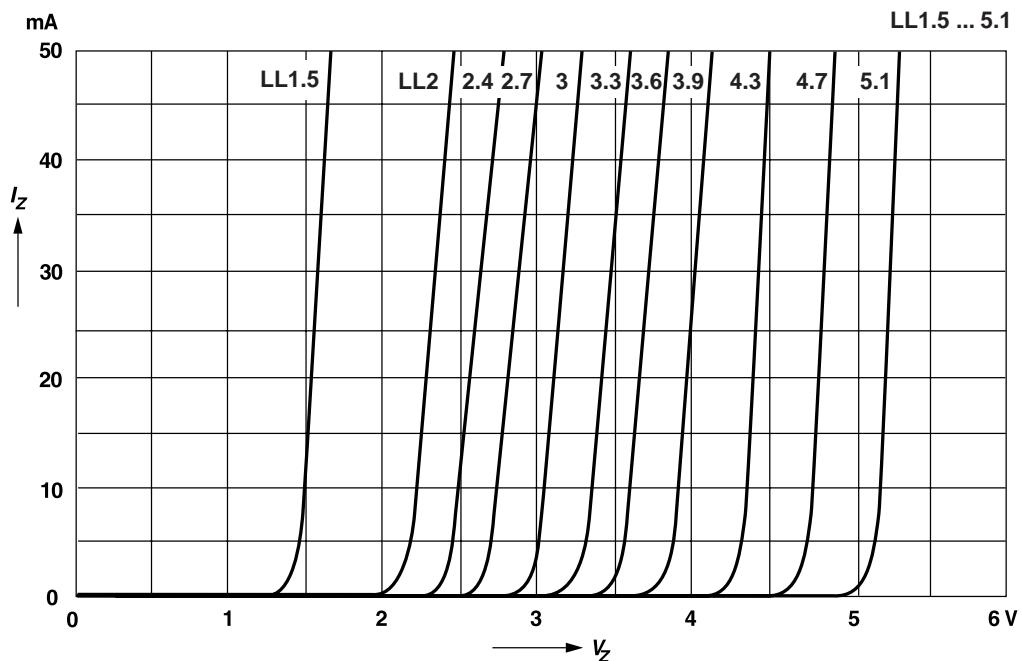
**Breakdown characteristics**

T<sub>j</sub> = constant (pulsed)



**Breakdown characteristics**

T<sub>j</sub> = constant (pulsed)

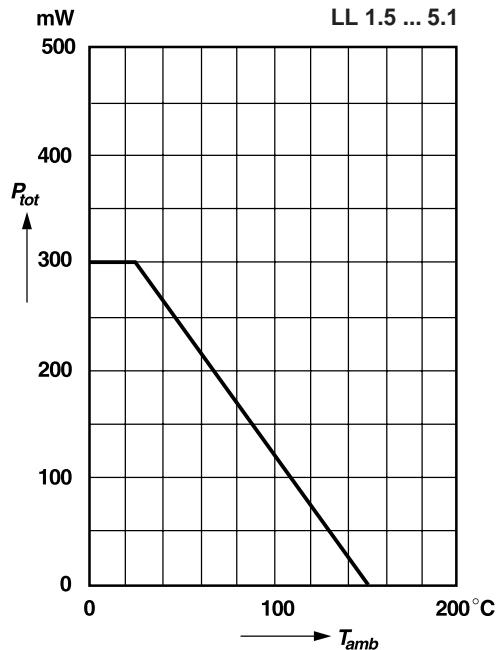


# Voltage Stabilizers

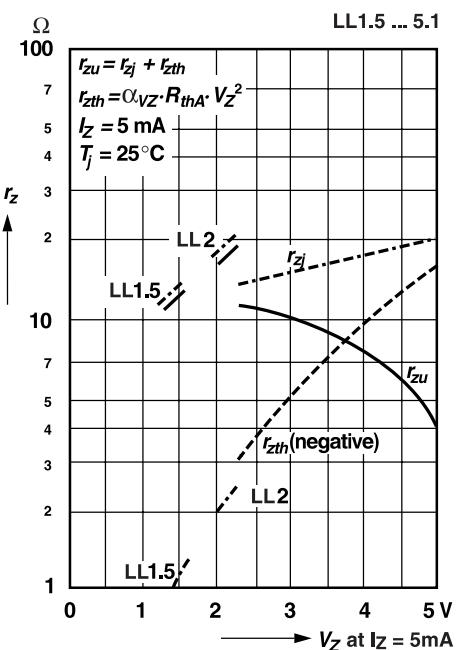
## Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

### Admissible power dissipation versus ambient temperature

Valid provided that leads at a distance of 8 mm from case  
are kept at ambient temperature



### Dynamic resistance versus operating voltage



### Dynamic resistance versus operating current, normalized

